





an Open Access Journal by MDPI

### **Technical Advances in Semiconductor Process**

Guest Editors:

#### Dr. Kangchun Lee

Department of Electronic Engineering, Kyonggi University, Gyeonggi-do 154-42, Republic of Korea

#### Dr. Kiho Bae

Semiconductor R&D Center, Samsung Electronics, Hwaseong 18448, Republic of Korea

Deadline for manuscript submissions:

20 August 2024

## **Message from the Guest Editors**

Dear Colleagues,

The development of nanoscale semiconductor processing has been driven by the structural innovation of devices and application of new materials for the last two decades. Especially, in the era of sub-3 nm gate-all-around fieldeffect-transistor (GAAFET) devices, as the contact poly pitch (CPP) is reduced to less than 45 nm. research on the advanced technologies, such **EUV-based** as nanopatterning processes, novel metal processes with low resistance, and inventive scheme processes (i.e., BSPDN: Back Side Power Delivery Network), have garnered notable attention in realizing next-generation semiconductor devices

This Special Issue will cover recent advances and comprehensive strategies in our fundamental understanding, advanced technologies, and new material development, with a focus on semiconductor processing for next-generation technology nodes. This will bring together a diverse set of leading researchers and engineers from academia to industry who focus on new materials, advances in materials characterization, material design, process modeling, and fundamental science in the semiconductor manufacturing field.











an Open Access Journal by MDPI

#### **Editor-in-Chief**

# **Prof. Dr. Giulio Nicola Cerullo**Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32, 20133 Milano, Italy

## **Message from the Editor-in-Chief**

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network

#### **Author Benefits**

**Open Access:** free for readers, with article processing charges (APC) paid by authors or their institutions.

**High Visibility:** indexed within Scopus, SCIE (Web of Science), Inspec, CAPlus / SciFinder, and other databases.

**Journal Rank:** JCR - Q1 (Engineering, Multidisciplinary) / CiteScore - Q1 (General Engineering)

#### **Contact Us**